


Schedule of Accreditation

issued by

United Kingdom Accreditation Service

21 - 47 High Street, Feltham, Middlesex, TW13 4UN, UK

 <p>UKAS CALIBRATION</p> <p>0452</p> <p>Accredited to ISO/IEC 17025:2005</p>	<h3>Electronic Test and Calibration Ltd</h3> <p>Issue No: 019 Issue date: 14 July 2010</p>	
	<p>Caddsdwn Industrial Estate Clovelly Road Bideford Devon EX39 3DX</p>	<p>Contact: Mr B D Wragge-Morley Tel: +44 (0)1237 423388 Fax: +44 (0)1237 423434 E-Mail: info@etcal.co.uk Website: www.etcal.co.uk</p>
<p>Calibration performed at the above address only</p>		

DETAIL OF ACCREDITATION

Measured Quantity Instrument or Gauge	Range	Calibration and Measurement Capability (CMC) Expressed as an Expanded Uncertainty (k = 2)	Remarks
DC RESISTANCE	100 $\mu\Omega$ to 10 M Ω 10 m Ω to 1.0 Ω 1.0 Ω to 20 Ω 20 Ω to 200 Ω 200 Ω to 2.0 k Ω 2.0 k Ω to 20 k Ω 20 k Ω to 200 k Ω 200 k Ω to 2.0 M Ω 2.0 M Ω to 10 M Ω	270 ppm + 0.30 $\mu\Omega$ 120 ppm + 1.0 $\mu\Omega$ 15 ppm + 80 $\mu\Omega$ 12 ppm 11 ppm 12 ppm 11 ppm 28 ppm 30 ppm	Measurement and generation
	10 M Ω to 2.5 G Ω 2.5 G Ω to 250 G Ω 250 G Ω to 2.0 T Ω	0.040 % 0.060 % 0.15 %	Measurement only
	10 Ω 100 Ω 1.0 k Ω 10 k Ω 100 k Ω 1.0 M Ω 10 M Ω 10 M Ω to 2.5 G Ω 2.5 G Ω to 250 G Ω 250 G Ω to 2.0 T Ω	10 ppm 8.0 ppm 8.0 ppm 8.0 ppm 8.0 ppm 20 ppm 20 ppm 0.040 % 0.060 % 0.15 %	Generation only
DC VOLTAGE	0 mV to 200 mV 200 mV to 2.0 V 2.0 V to 20 V 20 V to 200 V 200 V to 1000 V 1.0 kV to 40 kV	13 ppm + 0.50 μ V 10 ppm 10 ppm 11 ppm 14 ppm 0.15 %	Sources available up to 30 kV
DC CURRENT	20 μ A to 200 μ A 200 μ A to 200 mA 200 mA to 1.0 A 1.0 A to 10 A 10 A to 100 A	20 ppm 17 ppm 27 ppm 100 ppm 0.15 %	Measurement and generation



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DC CURRENT (cont'd)	10 pA to 2.0 nA 2.0 nA to 200 nA 200 nA to 20 μ A 100 A to 250 A 250 A to 1000 A	0.090 % 0.045 % 0.020 % 0.17 % 0.31 %	Measurement only
	10 pA to 2.0 nA 2.0 nA to 200 nA 200 nA to 20 μ A	0.12 % 0.050 % 0.030 %	Generation only
AC VOLTAGE	100 mHz to 10 Hz 2.5 mV _{rms} to 707 V _{rms} (1000 V _{pk})	0.15 % + 5.0 μ V	
	10 Hz to 30 Hz 200 mV to 2.0 V 2.0 V to 20 V 20 V to 200 V	200 ppm 200 ppm 200 ppm	
	30 (40) Hz to 300 Hz 2.0 mV to 200 mV 200 mV to 2.0 V 2.0 V to 20 V 20 V to 200 V 200 V to 1000 V	190 ppm + 5.0 μ V 120 ppm 125 ppm 125 ppm 140 ppm	
	300 Hz to 1.0 kHz 2.0 mV to 200 mV 200 mV to 2.0 V 2.0 V to 20 V 20 V to 200 V 200 V to 1000 V	170 ppm + 5.0 μ V 120 ppm 130 ppm 130 ppm 140 ppm	
	1.0 kHz to 10 kHz 2.0 mV to 200 mV 200 mV to 2.0 V 2.0 V to 20 V 20 V to 200 V 200 V to 1000 V	200 ppm + 5.0 μ V 170 ppm 170 ppm 170 ppm 180 ppm	
	10 kHz to 30 kHz 2.0 mV to 200 mV 200 mV to 2.0 V 2.0 V to 20 V 20 V to 200 V 200 V to 1000 V	400 ppm + 5.0 μ V 300 ppm 300 ppm 300 ppm 300 ppm	
	30 kHz to 100 kHz 2.0 mV to 200 mV 200 mV to 2.0 V 2.0 V to 20 V 20 V to 200 V 200 V to 700 V	600 ppm + 5.0 μ V 350 ppm 350 ppm 500 ppm 550 ppm	



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AC VOLTAGE (cont'd)	<i>100 kHz to 300 kHz</i> 200 mV to 2.0 V 2.0 V to 20 V <i>300 kHz to 1.0 MHz</i> 200 mV to 2.0 V 2.0 V to 20 V <i>40 Hz to 1000 Hz</i> 1.0 kV to 4.0 kV <i>At 50 Hz</i> 1.0 kV to 27 kV	0.10 % 0.10 % 0.50 % 0.50 % 1.0 % 0.30 %	Sources are available up to 6.0 kV at 50 Hz only
AC CURRENT	<i>10 Hz to 30 Hz</i> 10 uA to 200 uA 200 uA to 2.0 mA 2.0 mA to 20 mA 20 mA to 200 mA 200 mA to 1.0 A <i>30 Hz to 1.0 kHz</i> 10 uA to 200 uA 200 uA to 2.0 mA 2 mA to 20 mA 20 mA to 200 mA 200 mA to 1.0 A 1.0 A to 10 A <i>1.0 kHz to 5.0 kHz</i> 10 uA to 200 uA 200 uA to 2.0 mA 2.0 mA to 20 mA 20 mA to 200 mA 200 mA to 1.0 A 1.0 A to 10 A	200 ppm 200 ppm 200 ppm 200 ppm 250 ppm 200 ppm 200 ppm 200 ppm 200 ppm 250 ppm 310 ppm 300 ppm 300 ppm 300 ppm 300 ppm 400 ppm 500 ppm	
CAPACITANCE	<i>Frequency 100 Hz and 1.0 kHz</i> 10 pF to 100 nF 100 pF to 1.0 μF 1.0 μF to 10 μF 10 μF to 100 μF	0.20 % 0.050 % 0.070 % 0.30 %	Measurement and generation
DISSIPATION FACTOR	<i>Frequency 1.0 kHz</i> 0 to 0.01 0.01 to 0.1 0.1 to 0.5 0.5 to 1.0	0.000 26 0.000 27 0.000 54 0.000 85	Dissipation factor ($\tan \delta$) can be reported for capacitance values in the range 1.0 nF to 10 μF
INDUCTANCE	<i>At 100 Hz and 1.0 kHz</i> 1.0 μH to 10 μH 10 μH to 100 μH 100 μH to 10 H	0.90 % 0.30 % 0.15 %	Measurement capability only. The generation of known inductance values may be undertaken over the range of 1.0 mH to 1.0 H but the uncertainties may be increased.



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FREQUENCY MEASUREMENT			
Specific Values	1.0 MHz and 10 MHz	1 in 10 ¹⁰	Can be expressed as time (1/f) for repetitive wave forms
Other Values	1.0 Hz to 1.0 GHz 1.0 GHz to 26.5 GHz	16 in 10 ⁹ 16 in 10 ⁹	Generation limited to 20 GHz
TIME INTERVAL	10 ⁻⁵ s to 1.0 ns	16 in 10 ⁹ + 1.3 ns (Full waveform) 17 in 10 ⁹ + 1.3 ns (Part waveform)	Single Event
HARMONIC AMPLITUDE	30 mV to 300 V	5.8 % of full-scale deflection	Full-scale ranges from 30 mV to 300 V in 3-10-30 sequence. All frequency components must be in the range 10 Hz to 76 kHz.
DISTORTION FACTOR	300 mV to 100 V	3.5 % of full-scale deflection	Fundamental frequency range 20 Hz to 20 kHz; distortion component range up to 100 kHz. Full-scale ranges from 300 mV to 100 V in 3-10-30 sequence.
TEMPERATURE	0 °C to 100 °C	0.25 °C	As a support activity for determination of reference junction temperature when simulating temperature measurements electrically
ELECTRICAL SIMULATION OF TEMPERATURE			
Thermocouple			Measurement and Generation linearity
Type K	-270 °C to 1372 °C	0.050 % + 2.0 μV	
Type J	-210 °C to 1200 °C	0.050 % + 2.0 μV	
Type E	-270 °C to 1000 °C	0.050 % + 2.0 μV	
Type N	-270 °C to 1300 °C	0.050 % + 2.0 μV	
Type T	-270 °C to 400 °C	0.050 % + 2.0 μV	
Type S	0 °C to 1768 °C	0.050 % + 2.0 μV	
Type R	0 °C to 1768 °C	0.050 % + 2.0 μV	
Type B	0 °C to 1820 °C	0.050 % + 2.0 μV	
Thermocouple CJC		0.30 °C	
PRT	-200 °C to 850 °C	0.050 % + 10 mΩ	



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RF POWER	- 60 dBm to + 20 dBm 10 kHz to 10 MHz	0.080 dB	50 ohm systems only
	- 70 dBm to - 20 dBm 10 MHz to 50 MHz 50 MHz to 1.0 GHz 1.0 GHz to 5.0 GHz 5.0 GHz to 10 GHz 10 GHz to 15 GHz 15 GHz to 18 GHz	2.1 % 1.7 % 1.8 % 2.3 % 3.1 % 3.1 %	
	- 20 dBm to + 20 dBm 10 MHz to 50 MHz 50 MHz to 1.0 mW 50 MHz to 1.0 GHz 1.0 GHz to 5.0 GHz 5.0 GHz to 10 GHz 10 GHz to 15 GHz 15 GHz to 18 GHz	1.4 % 0.8 % 1.1 % 1.3 % 1.6 % 1.7 % 1.7 %	
	+ 20 dBm to + 47 dBm 10 MHz to 30 MHz 30 MHz to 1.0 GHz 1.0 GHz to 5.0 GHz 5.0 GHz to 18 GHz	0.24 dB 0.23 dB 0.23 dB 0.28 dB	
Calibration Factor	100 kHz to 0.5 MHz	0.60 %	50 ohm systems only. Nominal level + 10 dBm.
	0.5 MHz to 1.0 MHz 1.0 MHz to 5.0 MHz 5.0 MHz to 10 MHz	0.70 % 0.70 % 0.70 %	
	10 MHz to 50 MHz	1.5 %	50 ohm systems only. Nominal level 0 dBm.
	50 MHz to 1.0 GHz 1.0 GHz to 5.0 GHz 5.0 GHz to 10 GHz 10 GHz to 15 GHz 15 GHz to 18 GHz	0.80 % 1.0 % 1.6 % 1.6 % 1.8 %	
	10 MHz to 50 MHz	1.4 %	50 ohm systems only. Nominal level - 30 dBm.
	50 MHz to 1.0 GHz 1.0 GHz to 5.0 GHz 5.0 GHz to 10 GHz 10 GHz to 15 GHz 15 GHz to 18 GHz	0.90 % 1.1 % 1.8 % 2.0 % 2.2 %	
RF VOLTAGE	30 μ V to 3.17 V 10 kHz to 10 MHz 10 MHz to 300 MHz 300 MHz to 1.0 GHz 1.0 GHz to 2.0 GHz	1.9 % 1.8 % 3.2 % 14 %	50 ohm systems only



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VOLTAGE REFLECTION COEFFICIENT	<i>5.0 MHz to 1.0 GHz</i>		50 ohm systems only
	0.00 to 0.05	0.011	
	0.05 to 0.1	0.015	
	0.1 to 0.2	0.028	
	0.2 to 0.7	0.089	
	0.7 to 1.0	0.12	
	<i>1.0 GHz to 2.0 GHz</i>		
	0.00 to 0.05	0.017	
	0.05 to 0.1	0.018	
	0.1 to 0.2	0.026	
	0.2 to 0.7	0.068	
	0.7 to 1.0	0.091	
	<i>2.0 GHz to 5.0 GHz</i>		
	0.00 to 0.05	0.021	
	0.05 to 0.1	0.034	
	0.1 to 0.2	0.065	
	0.2 to 0.7	0.22	
	0.7 to 1.0	0.32	
	<i>5.0 GHz to 10 GHz</i>		
	0.00 to 0.05	0.026	
	0.05 to 0.1	0.028	
	0.1 to 0.2	0.038	
	0.2 to 0.7	0.11	
	0.7 to 1.0	0.14	
<i>10 GHz to 15 GHz</i>			
0.00 to 0.05	0.033		
0.05 to 0.1	0.035		
0.1 to 0.2	0.042		
0.2 to 0.7	0.093		
0.7 to 1.0	0.13		
<i>15 GHz to 18 GHz</i>			
0.00 to 0.05	0.035		
0.05 to 0.1	0.038		
0.1 to 0.2	0.050		
0.2 to 0.7	0.13		
0.7 to 1.0	0.18		
RF ATTENUATION (Insertion loss method)	0 dB to 80 dB <i>10 kHz to 1.0 GHz</i>	0.37 dB	50 ohm systems only
	0 dB to 60 dB <i>1.0 GHz to 18 GHz</i>	0.39 dB	
	60 dB to 80 dB <i>1.0 GHz to 18 GHz</i>	1.0 dB	



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RF ATTENUATION (Substitution method)	0 dB to 80 dB <i>10 kHz to 1.0 GHz</i>	0.32 dB	50 ohm systems only
	80 dB to 120 dB <i>10 kHz to 1.0 GHz</i>	2.5 dB	
	0 dB to 25 dB <i>10 MHz to 50 MHz</i> <i>50 MHz to 1.0 GHz</i> <i>1.0 GHz to 5.0 GHz</i> <i>5.0 GHz to 10 GHz</i> <i>10 GHz to 15 GHz</i> <i>15 GHz to 18 GHz</i>	0.060 dB 0.030 dB 0.040 dB 0.050 dB 0.060 dB 0.070 dB	
	25 dB to 60 dB <i>10 MHz to 50 MHz</i> <i>50 MHz to 1.0 GHz</i> <i>1.0 GHz to 5.0 GHz</i> <i>5.0 GHz to 10 GHz</i> <i>10 GHz to 15 GHz</i> <i>15 GHz to 18 GHz</i>	0.040 dB 0.040 dB 0.040 dB 0.060 dB 0.080 dB 0.10 dB	
FREQUENCY MODULATION	60 dB To 70 dB <i>10MHz to 50MHz</i> <i>50MHz to 1.0 GHz</i> <i>1.0 GHz to 5.0 GHz</i> <i>5.0 GHz to 10 GHz</i> <i>10 GHz to 15 GHz</i> <i>15 GHz to 18 GHz</i>	0.24 dB 0.24 dB 0.24 dB 0.24 dB 0.24 dB 0.25 dB	
	0 Hz to 40 kHz	2.6 % + 2.0 Hz	Carrier frequency range 250 kHz to 10 MHz; modulation frequency range 20 Hz to 10 kHz
	0 Hz to 400 kHz	1.6 % + 16 Hz	Carrier frequency range 10 MHz to 1.3 GHz; modulation frequency range 20 Hz to 200 kHz
	0 Hz to 300 kHz	6.0 % + 200 Hz	Carrier frequency range 1.3 GHz to 18 GHz; modulation frequency range 20 Hz to 100 kHz



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AMPLITUDE MODULATION	0 to 0.05	4.3 % + 0.00020	Ranges and uncertainties are shown in terms of modulation index Carrier frequency range 150 kHz to 10 MHz; modulation frequency range 20 Hz to 10 kHz.
	0.05 to 0.3	3.1 % + 0.00020	
	0.3 to 0.5	2.8 % + 0.0020	
	0.5 to 0.9	2.6 % + 0.0020	
	0 to 0.05	3.7 % + 0.00020	Carrier frequency range 10 MHz to 1.3 GHz; modulation frequency range 20 Hz to 100 kHz.
	0.05 to 0.3	3.7 % + 0.00020	
	0.3 to 0.5	1.8 % + 0.0020	
	0.5 to 0.9	1.6 % + 0.0020	
	0 to 0.05	5.6 % + 0.0020	Carrier frequency range 1.0 GHz to 18 GHz; modulation frequency range 200 Hz to 100 kHz.
	0.05 to 0.3	4.8 % + 0.0020	
	0.3 to 0.5	4.6 % + 0.0050	
	0.5 to 0.9	4.6 % + 0.0050	
PHASE MODULATION	0 radians to 400 radians	3.7 % + 0.0020 radians	Carrier frequency range 10 MHz to 1.3 GHz; modulation frequency range 20 Hz to 20 kHz
RF INTERMODULATION PRODUCTS	0 dB to -80 dB <i>10 kHz to 110 MHz</i> <i>110 MHz to 18 GHz</i>	0.94 dB 1.9 dB	
PULSE RISETIME AND FALLTIME	1.0 ns to 1.0 s	3.7 %	
ELECTROSTATIC VOLTAGE	0.1 kV to 30 kV	1.0 %	Fieldmeters for measuring charged surfaces
HIGH IMPEDANCE CONTACT VOLTAGE	0.1 kV to 30 kV	0.70 %	Electrostatic voltmeter and other high resistance voltmeters for measuring charged surfaces
ELECTROSTATIC DISCHARGE GENERATORS			
PULSE AMPLITUDE	0.1 kV to 30 kV	1.0 %	Contact voltmeter
PULSE AMPLITUDE	0.1 A to 30 A	2.8 %	ESD Target 1 st peak
RISE TIME	100 ps to 1.0 s	3.7 %	ESD Target
FALL TIME AMPLITUDE	0.1 A to 30 A	3.8 %	ESD Target
FALL TIME AMPLITUDE	100 ps to 1.0 s	3.7 %	ESD Target



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EMC - SPECIFIC EQUIPMENT MEASUREMENTS				
BURST TRANSIENT PULSES				
Risetime and falltime	1.0 ns to 1.0 s	2.2 %	For impedance calibration of line impedance stabilisation networks (LISNs)	
Repetition frequency	1.0 Hz to 1.0 MHz	0.030 %		
Burst Width	2.0 ms to 1.0 s	1.5 %		
Voltage amplitude	0.5 kV to 4.4 kV	2.9 %		
SURGE PULSE CHARACTERISTICS				
Risetime and falltime	0.1 μ s to 1.0 s	2.3 %		
Pulse width	0.6 μ s to 1.0 ms	1.5 %		
Repetition rate	1.0 s to 100 s	0.030 %		
Phase angle	0° to 360°	1.3°		
Voltage amplitude	0.25 kV to 6.6 kV	2.6 %		
Current amplitude	0.2 kA to 3.3 kA	2.9 %		
RF IMPEDANCE	5.0 Ω to 60 Ω 9.0 kHz to 30 MHz	4.6 %		
IMPULSE GENERATOR MEASUREMENTS	50 dB μ V to 110 dB μ V 9.0 kHz to 30 MHz 30 MHz to 300 MHz 300 MHz to 1.0 GHz	0.70 dB 1.0 dB 1.5 dB		
IMPULSE GENERATION				
Absolute and relative amplitude	50 dB μ V to 110 dB μ V 9.0 kHz to 150 kHz	0.25 dB		
Absolute amplitude	50 dB μ V to 110 dB μ V 150 kHz to 30 MHz 30 MHz to 300 MHz 300 MHz to 1.0 GHz	0.80 dB 1.1 dB 1.6 dB		
Relative amplitude	50 dB μ V to 110 dB μ V 150 kHz to 30 MHz 30 MHz to 300 MHz 300 MHz to 1.0 GHz	0.50 dB 0.60 dB 0.90 dB		
Voltage Dips, Short Interruptions Voltage Variations Generators				
Dip RMS Voltage	1 V to 400 V	2.3 %		
Voltage Variations	1 V to 400 V	3.5 %		
Interruptions Overshoot Voltage	25 % to 100 %	3.5 %		
Transition rise and fall time	1.0 μ s to 1.0 s	3.0 %		
Phase Angle	0° to 360°	11°		



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Damped Oscillatory Generator			
Voltage	1.0 V to 6.6 kV	2.7 %	
Ringwave Current	1.0 A to 3.3 kA	2.9 %	
Oscillatory Wave Current	1.0 A to 150 A	4.4 %	
Rise time	1.0 ns to 1.0 s	3.0 %	
Frequency	1 Hz to 1 GHz	2.3 %	
Repetition Rate	1.0 us to 1.0 s	2.3 %	
Duration	10 ns to 10 s	2.3 %	
Period	1.0 ns to 1.0 s	1.0 %	
Phase	0° to 360°	11°	
ANTENNA MEASUREMENTS			
Monopole Antenna Antenna Factor	20 Hz to 30 MHz 30 MHz to 100 MHz	1.4 dB/m 1.6 dB/m	Equivalent capacitance method
Antenna Factor & Apparent Gain			Best capability using the three antenna method or by comparison with similar antennas using the standard antenna method.
Biconical and Broad Band Dipoles	30 MHz to 300 MHz 300 MHz to 1.0 GHz	1.2 dB 1.2 dB	Measurement distance 10 m, 3.0 m and 1.0 m,
Log Periodic	80 MHz to 3.0 GHz	1.2 dB	Measurement distances 3.0 m and 1.0 m; calculated results for 10 m and for Free Space.
Bilog and hybrid antennas	30 MHz to 3.0 GHz	1.4 dB	Measurement distances 3.0 m and 1.0 m; calculated results for 10 m and for Free Space.
Horn Antennas	1.0 GHz to 18.0 GHz	1.2 dB	Horn measurement at 3.0 m and 1.0 m.
END			